

**July 2013** 

## FCPF190N60 F152

# N-Channel SuperFET $^{\mathbb{R}}$ II MOSFET 600 V, 20.2 A, 199 m $\Omega$

#### **Features**

- 650 V @T<sub>J</sub> = 150°C
- Max.  $R_{DS(on)} = 199 \text{ m}\Omega$
- Ultra low gate charge (typ. Q<sub>q</sub> = 57 nC)
- Low effective output capacitance (typ. C<sub>oss</sub>.eff = 160 pF)
- 100% avalanche tested

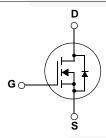
## **Aplications**

- LCD / LED / PDP TV Lighting
- · Solar Inverter
- AC-DC Power Supply

## Description

SuperFET<sup>®</sup>II MOSFET is Fairchild Semiconductor<sup>®</sup>, s first generation of high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. Consequently, SuperFET<sup>®</sup>II MOSFET is suitable for various AC/DC power conversion for system miniaturization and higher efficiency.





## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol		Parameter		FCPF190N60_F152	Unit
V <sub>DSS</sub>	Drain to Source Voltage			600	V
\/	Cata to Source Voltage	-DC		±20	V
$V_{GSS}$	Gate to Source Voltage	-AC	(f >1Hz)	±30	V
	Desir Comment	-Continuous (T <sub>C</sub> = 25°C)		20.2*	
ID	Drain Current	-Continuous (T <sub>C</sub> = 100°C)			A
I <sub>DM</sub>	Drain Current	- Pulsed			Α
E <sub>AS</sub>	Single Pulsed Avalanche End	ergy	(Note 2)	400	mJ
I <sub>AR</sub>	Avalanche Current	Avalanche Current (Note 1)		4.0	Α
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)		(Note 1)	2.1	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	20	V/ns
av/ai	MOSFET dv/dt			100	V/ns
D	Dower Discinction	$(T_C = 25^{\circ}C)$		39	W
$P_{D}$	Power Dissipation - Derate above 25°C			0.31	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temp	perature Range		-55 to +150	°C
T <sub>L</sub>	Maximum Lead Temperature 1/8" from Case for 5 Second	• •	300	°C	

\*Drain current limited by maximum junction temperature

#### Thermal Characteristics

Symbol	Parameter	FCPF190N60_F152	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.2	
$R_{\theta CS}$	Thermal Resistance, Case to Heat Sink (Typical)	0.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	

## **Package Marking and Ordering Information**

Device Marking	Device	Package	Eco Status	Packaging Type	Quantity
FCPF190N60	FCPF190N60_F152	TO-220F	Green 🏈	Tube	50

For Fairchild's definition of "green" Eco Status, please visit: http://www.fairchildsemi.com/company/green/rohs\_green.html.

## Electrical Characteristics T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics					
D\/	Drain to Source Prockdown Voltage	$V_{GS} = 0V, I_D = 10mA, T_J = 25^{\circ}C$	600	-	-	V
BV <sub>DSS</sub> Drain to Source Breakdown Voltage	Drain to Source Breakdown voltage	$V_{GS} = 0V, I_D = 10mA, T_J = 150^{\circ}C$	650	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{.l}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 10mA, Referenced to 25°C	-	0.67	-	V/°C
BV <sub>DS</sub>	Drain-Source Avalanche Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 20A	-	700	-	V
	Zoro Coto Voltogo Droin Current	V <sub>DS</sub> = 480V, V <sub>GS</sub> = 0V	-	-	10	^
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 480V, T_{C} = 125^{\circ}C$	-	-	10	μΑ
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

#### On Characteristics

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.5	-	3.5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 10A$	-	0.17	0.199	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 20V, I_{D} = 10A$	-	21	-	S

## **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 05V V 0V	- \	2220	2950	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz	-	1630	2165	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 – 1101112	-	85	128	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 380V, V_{GS} = 0V, f = 1MHz$	-	42	-	pF
C <sub>oss</sub> eff.	Effective Output Capacitance	$V_{DS} = 0V$ to 480V, $V_{GS} = 0V$	-	160	-	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V	V <sub>DS</sub> = 380V, I <sub>D</sub> = 10A	-	57	74	nC
$Q_{gs}$	Gate to Source Gate Charge	V <sub>GS</sub> = 10V	-	9	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	(Note 4)	-	21	-	nC
ESR	Equivalent Series Resistance	f = 1MHz	- /	1	-	Ω

## **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		-	20	50	ns
t <sub>r</sub>		$V_{DD} = 380V, I_{D} = 10A$	-	10	30	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10V, R_g = 4.7\Omega$	-	64	138	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4)	-	5	20	ns

## **Drain-Source Diode Characteristics**

I <sub>S</sub>	Maximum Continuous Drain to Source Diode Forward Current			-	20.2	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	_	60.6	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 10A	-	-	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 10A	-	280	\\ -	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	3.8	-	μС

#### Notes

- ${\bf 1.}\ Repetitive\ Rating:\ Pulse\ width\ limited\ by\ maximum\ junction\ temperature$
- 2.  $I_{AS}$  = 4A,  $V_{DD}$  = 50V,  $R_G$  = 25 $\Omega$ , Starting  $T_J$  = 25 $^{\circ}C$
- 3.  $I_{SD} \leq 10 A$ , di/dt  $\leq 200 A/\mu s$ ,  $V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$
- 4. Essentially Independent of Operating Temperature Typical Characteristics

## **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

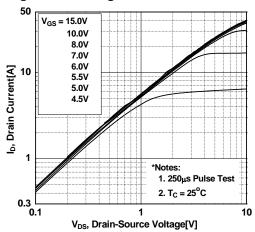


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

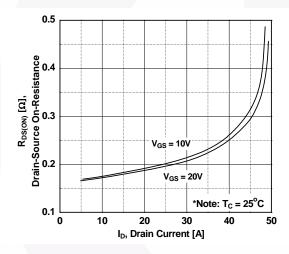


Figure 5. Capacitance Characteristics

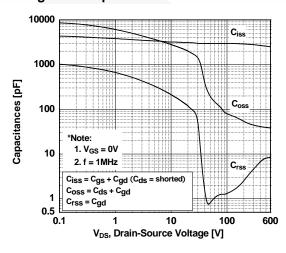


Figure 2. Transfer Characteristics

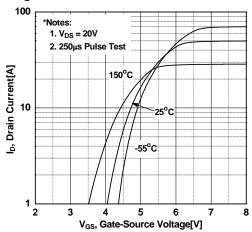


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

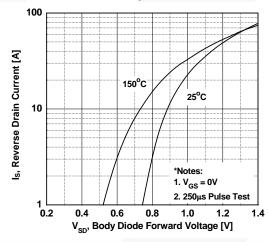
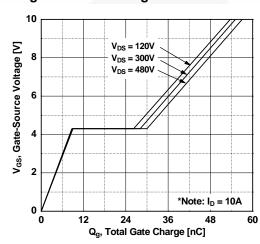


Figure 6. Gate Charge Characteristics



## **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

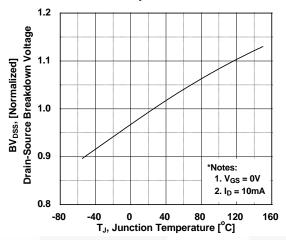
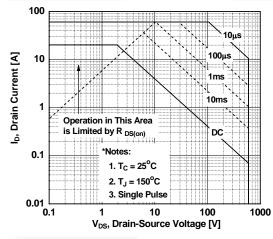


Figure 9. Maximum Safe Operating Area vs. Case Temperature



**Figure 11. Maximum Drain Current** 

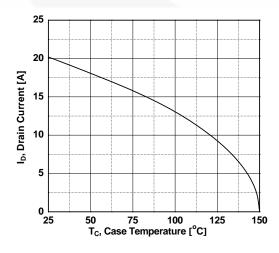


Figure 8. On-Resistance Variation vs. Temperature

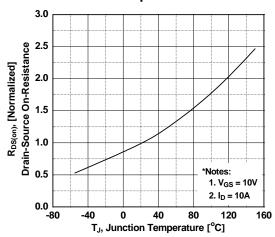
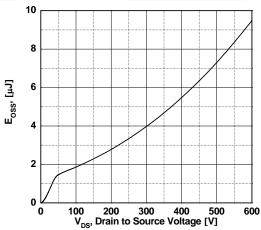
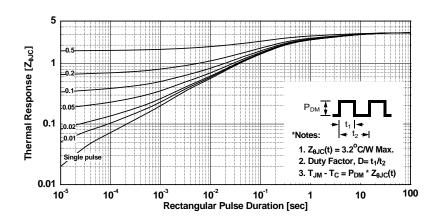


Figure 10. Eoss vs. Drain to Source Voltage Switching Capability

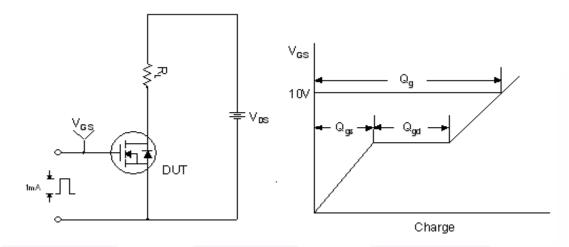


## **Typical Performance Characteristics** (Continued)

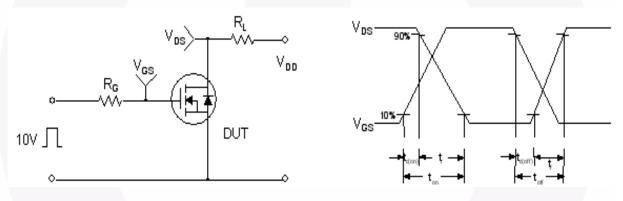
Figure 12. Transient Thermal Response Curve



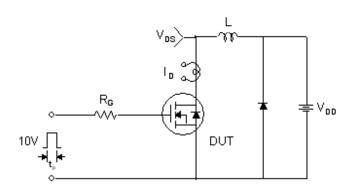
## **Gate Charge Test Circuit & Waveform**

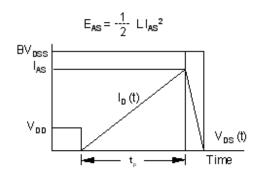


## **Resistive Switching Test Circuit & Waveforms**

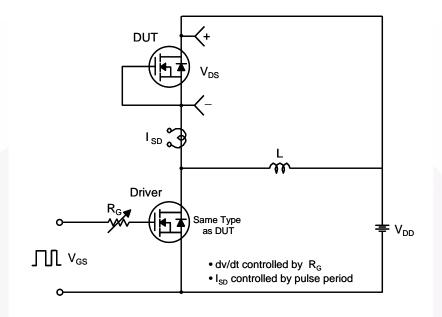


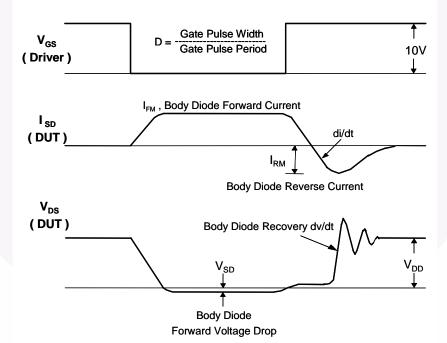
## **Unclamped Inductive Switching Test Circuit & Waveforms**





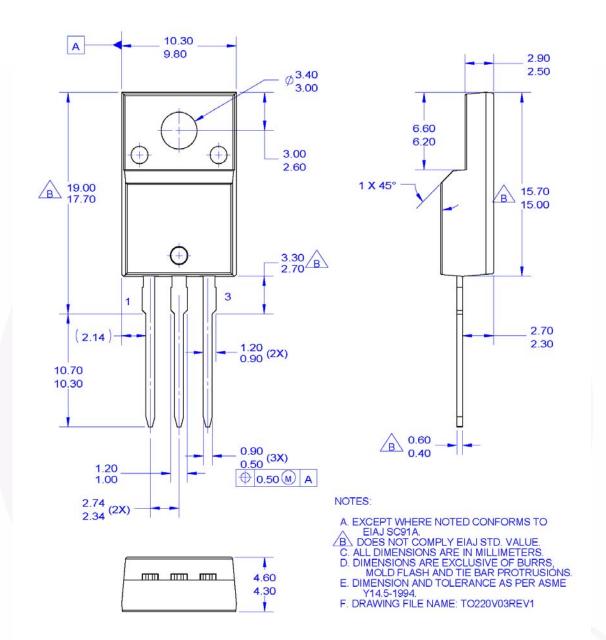
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms





## **Mechanical Dimensions**

## TO-220F



## \* Front/Back Side Isolation Voltage: AC 2500V

## TO-220, MOLDED, 3LD, FULL PACK, EIAJ SC91

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